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Appl	ication	/Control	No.
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Applicant(s)/Patent under Reexamination

10/815,239 Examiner

AHUJA ET AL. Art Unit

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Shin-Hon Chen

SEARCHED			
Class	Subclass	Date	Examiner
709	224,249	6/8/2007	S.C.
713	182,162	6/8/2007	S.C.
713	151	6/8/2007	S.C.
726	3,11,13	6/8/2007	S.C.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/8/2007	S.C.
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